

Final datasheet

EasyPACK™ 2B module with CoolSiC™ Trench MOSFET and PressFIT / NTC

Features

- Electrical features
 - $V_{DS} = 2000\text{ V}$
 - $I_{DN} = 160\text{ A}$ / $I_{DRM} = 320\text{ A}$
 - Overload operation up to 175°C
 - Suitable Infineon gate drivers can be found under <https://www.infineon.com/gdfinder>
- Mechanical features
 - AlN substrate with low thermal resistance
 - High creepage and clearance distances
 - Integrated NTC temperature sensor
 - PressFIT contact technology



Typical appearance

Potential applications

- EV charging
- Energy storage systems (ESS)
- Solar applications
- DC/DC converter

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

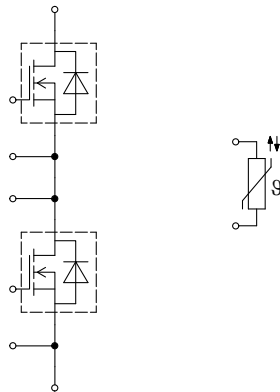


Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET, T1 / T2	3
3	Body diode (MOSFET, T1 / T2)	5
4	NTC-Thermistor	6
5	Characteristics diagrams	7
6	Circuit diagram	14
7	Package outlines	15
8	Module label code	16
	Revision history	17
	Disclaimer	18

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.2	kV
Isolation test voltage NTC	$V_{ISOL(NTC)}$	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.2	kV
Internal isolation		basic insulation (class 1, IEC 61140)	AIN	
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{SCE}			9		nH
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25 \text{ °C}$, per switch		1.3		mΩ
Storage temperature	T_{stg}		-40		125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

Note: The current under continuous operation is limited to 25 A RMS per connector pin.

2 MOSFET, T1 / T2

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		$T_{vj} = 25 \text{ °C}$	2000	V
Implemented drain current	I_{DN}			160	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	$T_H = 75 \text{ °C}$	160	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}		320	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$		-10/23	V
Gate-source voltage, max. static voltage	V_{GS}			-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...-2	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 160\text{ A}$	$V_{GS} = 18\text{ V}, T_{vj} = 25\text{ °C}$		5.1	8.1	mΩ
			$V_{GS} = 18\text{ V}, T_{vj} = 125\text{ °C}$		10.9		
			$V_{GS} = 18\text{ V}, T_{vj} = 175\text{ °C}$		15.4		
			$V_{GS} = 15\text{ V}, T_{vj} = 25\text{ °C}$		5.6		
Gate threshold voltage	$V_{GS(th)}$	$I_D = 112\text{ mA}, V_{DS} = V_{GS}, (\text{tested after 1ms pulse at } V_{GS} = +20\text{ V}), T_{vj} = 25\text{ °C}$		3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DD} = 1200\text{ V}, V_{GS} = -3\text{ V}, T_{vj} = 25\text{ °C}$			0.78		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25\text{ °C}$			1.8		Ω
Input capacitance	C_{ISS}	$f = 100\text{ kHz}, V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		24.1		nF
Output capacitance	C_{OSS}	$f = 100\text{ kHz}, V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.563		nF
Reverse transfer capacitance	C_{rSS}	$f = 100\text{ kHz}, V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.041		nF
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 1200\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$			508		μJ
Drain-source leakage current	I_{DSS}	$V_{DS} = 2000\text{ V}, V_{GS} = -3\text{ V}$	$T_{vj} = 25\text{ °C}$		0.04	378	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0\text{ V}, T_{vj} = 25\text{ °C}$	$V_{GS} = 20\text{ V}$			400	nA
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 160\text{ A}, R_{Gon} = 1.8\text{ Ω}, V_{DD} = 1200\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}$	$T_{vj} = 25\text{ °C}$		65		ns
			$T_{vj} = 125\text{ °C}$		64		
			$T_{vj} = 175\text{ °C}$		63		
Rise time (inductive load)	t_r	$I_D = 160\text{ A}, R_{Gon} = 1.8\text{ Ω}, V_{DD} = 1200\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}$	$T_{vj} = 25\text{ °C}$		53		ns
			$T_{vj} = 125\text{ °C}$		53		
			$T_{vj} = 175\text{ °C}$		56		

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 160\text{ A}$, $R_{Goff} = 0.51\ \Omega$, $V_{DD} = 1200\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	105		ns
			$T_{vj} = 125\text{ °C}$	117		
			$T_{vj} = 175\text{ °C}$	117		
Fall time (inductive load)	t_f	$I_D = 160\text{ A}$, $R_{Goff} = 0.51\ \Omega$, $V_{DD} = 1200\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	23		ns
			$T_{vj} = 125\text{ °C}$	25		
			$T_{vj} = 175\text{ °C}$	25		
Turn-on energy loss per pulse	E_{on}	$I_D = 160\text{ A}$, $V_{DD} = 1200\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon} = 1.8\ \Omega$, $di/dt =$ $12\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$), $t_{dead} = 1000\text{ ns}$	$T_{vj} = 25\text{ °C}$	8		mJ
			$T_{vj} = 125\text{ °C}$	10.6		
			$T_{vj} = 175\text{ °C}$	12.9		
Turn-on energy loss per pulse, optimized	$E_{on,o}$	$I_D = 160\text{ A}$, $V_{DD} = 1200\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon,o} = 0.51\ \Omega$, $di/dt =$ $15.4\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$), $t_{dead} = 100\text{ ns}$	$T_{vj} = 25\text{ °C}$	5.8		mJ
			$T_{vj} = 125\text{ °C}$	6.2		
			$T_{vj} = 175\text{ °C}$	6.4		
Turn-off energy loss per pulse	E_{off}	$I_D = 160\text{ A}$, $V_{DD} = 1200\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Goff} = 0.51\ \Omega$, $dv/dt =$ $38.4\text{ kV}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$)	$T_{vj} = 25\text{ °C}$	1.8		mJ
			$T_{vj} = 125\text{ °C}$	2		
			$T_{vj} = 175\text{ °C}$	2.1		
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, $\lambda_{grease} = 5\text{ W}/(\text{m}\cdot\text{K})$		0.152		K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	°C

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.
 $T_{vj\ op} > 150\text{ °C}$ is allowed for operation at overload conditions. For detailed specifications, please refer to AN 2018-14.

3 Body diode (MOSFET, T1 / T2)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175\text{ °C}$, $V_{GS} = -3\text{ V}$	$T_H = 65\text{ °C}$	140	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 160 \text{ A}$, $V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ °C}$	4.4	5.95	V
			$T_{vj} = 125 \text{ °C}$	4		
			$T_{vj} = 175 \text{ °C}$	3.85		
Peak reverse recovery current	I_{rrm}	$I_{SD} = 160 \text{ A}$, $di_s/dt = 12 \text{ kA}/\mu\text{s}$, $V_{DD} = 1200 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ °C}$	148		A
			$T_{vj} = 125 \text{ °C}$	227		
			$T_{vj} = 175 \text{ °C}$	283		
Recovered charge	Q_{rr}	$I_{SD} = 160 \text{ A}$, $di_s/dt = 12 \text{ kA}/\mu\text{s}$, $V_{DD} = 1200 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ °C}$	3.4		μC
			$T_{vj} = 125 \text{ °C}$	6.7		
			$T_{vj} = 175 \text{ °C}$	9.3		
Reverse recovery energy	E_{rec}	$I_{SD} = 160 \text{ A}$, $di_s/dt = 12 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ °C}$), $V_{DD} = 1200 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ °C}$	2		mJ
			$T_{vj} = 125 \text{ °C}$	2.8		
			$T_{vj} = 175 \text{ °C}$	3.8		
Reverse recovery energy, optimized	$E_{rec,o}$	$I_{SD} = 160 \text{ A}$, $di_s/dt = 15.4 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ °C}$), $V_{DD} = 1200 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 100 \text{ ns}$	$T_{vj} = 25 \text{ °C}$	0.89		mJ
			$T_{vj} = 125 \text{ °C}$	0.89		
			$T_{vj} = 175 \text{ °C}$	0.91		

4 NTC-Thermistor

Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25 \text{ °C}$		5		k Ω
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100 \text{ °C}$, $R_{100} = 493 \text{ }\Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25 \text{ °C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

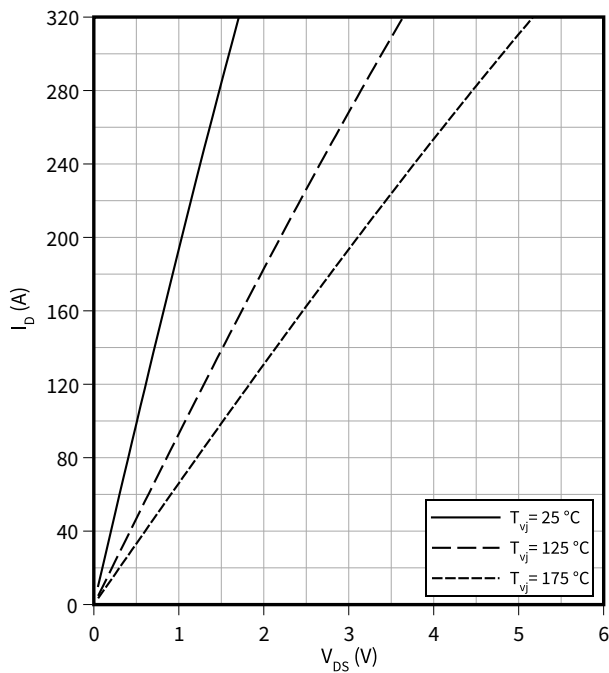
Note: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4

5 Characteristics diagrams

Output characteristic (typical), MOSFET, T1 / T2

$I_D = f(V_{DS})$

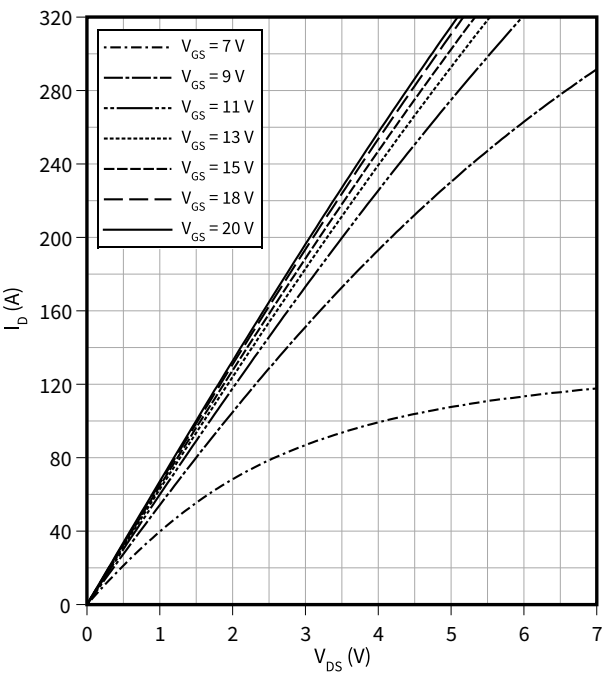
$V_{GS} = 18\text{ V}$



Output characteristic field (typical), MOSFET, T1 / T2

$I_D = f(V_{DS})$

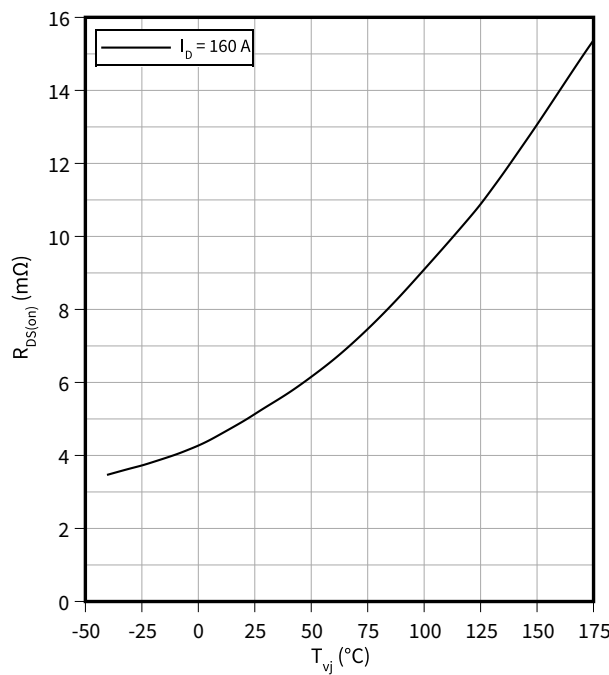
$T_{vj} = 175^\circ\text{C}$



Drain source on-resistance (typical), MOSFET, T1 / T2

$R_{DS(on)} = f(T_{vj})$

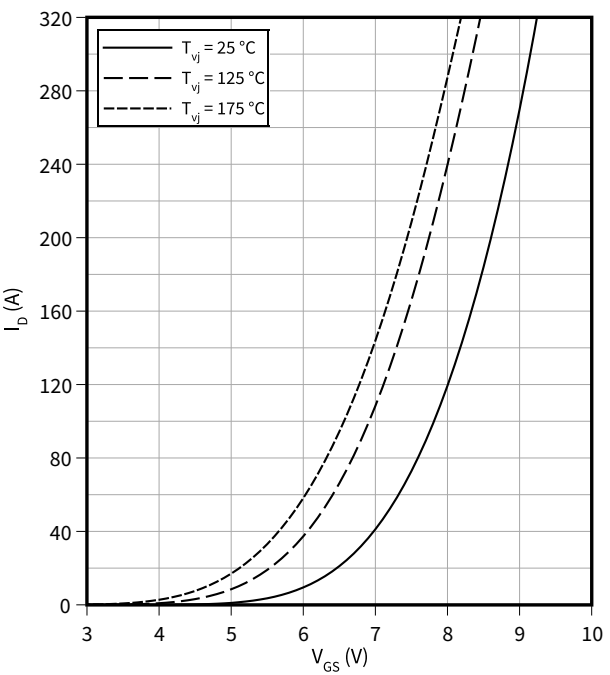
$V_{GS} = 18\text{ V}$



Transfer characteristic (typical), MOSFET, T1 / T2

$I_D = f(V_{GS})$

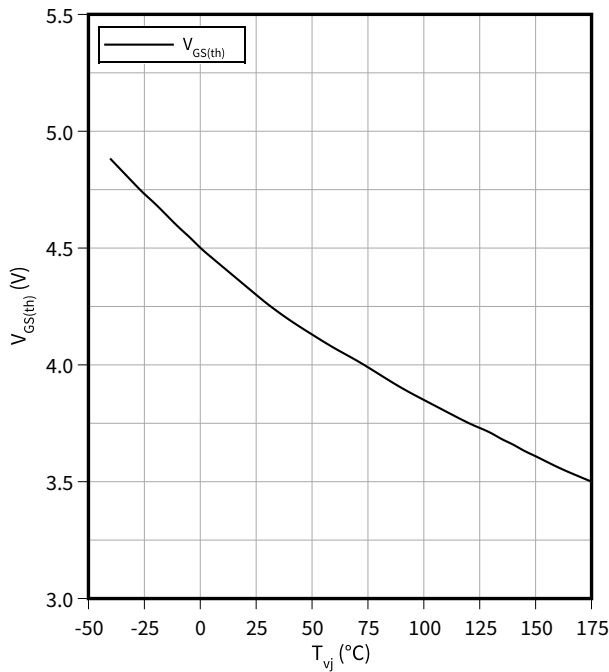
$V_{DS} = 20\text{ V}$



5 Characteristics diagrams

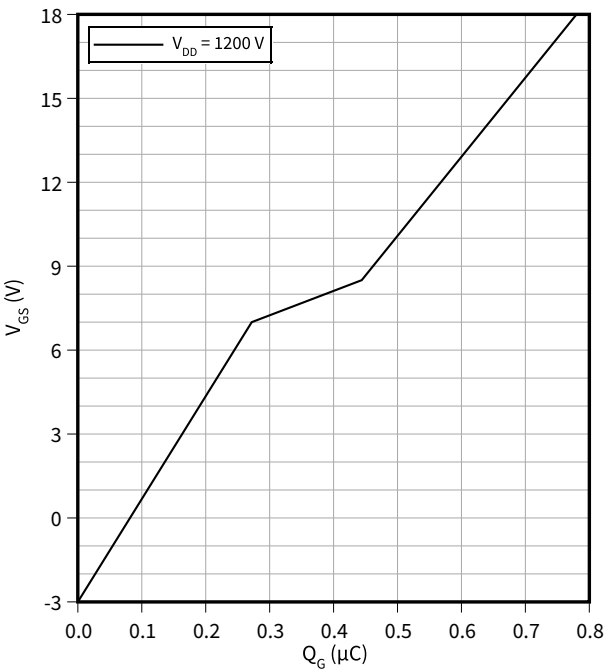
Gate-source threshold voltage (typical), MOSFET, T1 / T2

$V_{GS(th)} = f(T_{vj})$
 $I_D = 112 \text{ mA}, V_{GS} = V_{DS}$



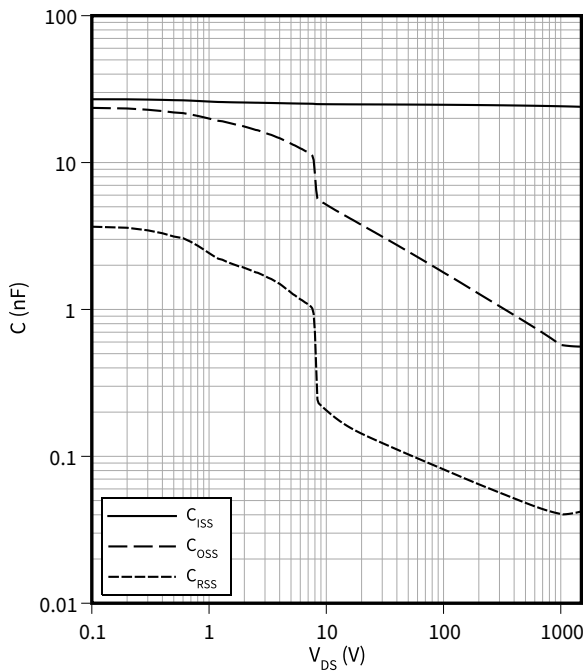
Gate charge characteristic (typical), MOSFET, T1 / T2

$V_{GS} = f(Q_G)$
 $I_D = 160 \text{ A}, T_{vj} = 25 \text{ }^\circ\text{C}$



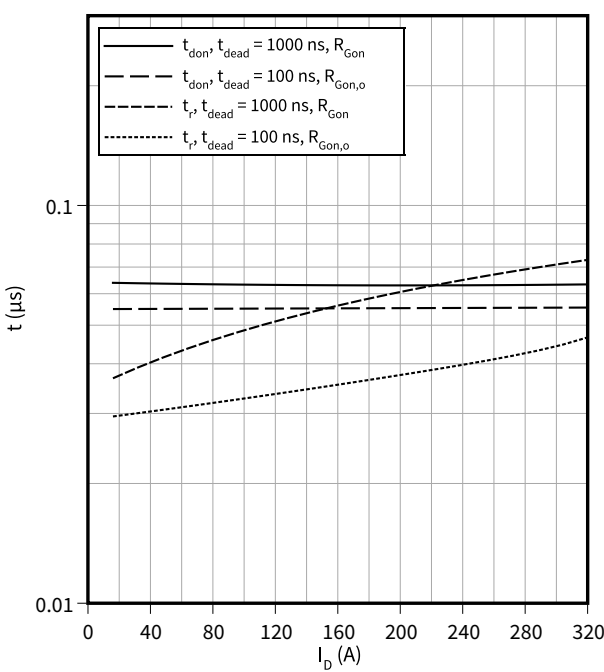
Capacity characteristic (typical), MOSFET, T1 / T2

$C = f(V_{DS})$
 $f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{GS} = 0 \text{ V}$



Switching times (typical), MOSFET, T1 / T2

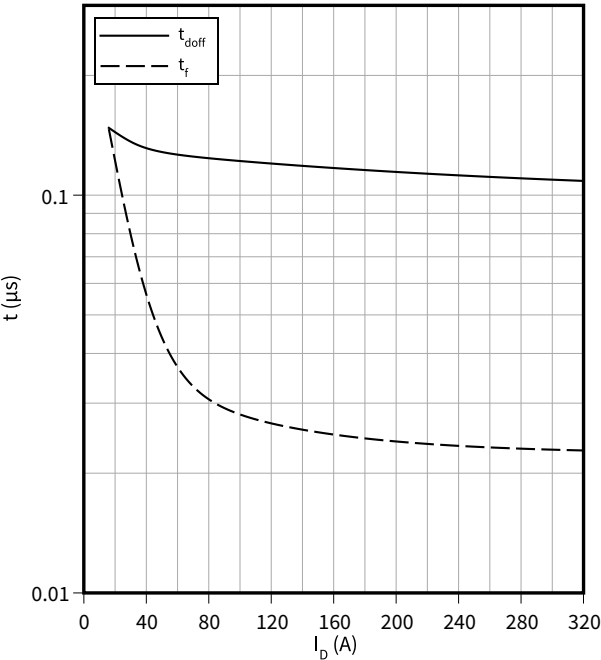
$t = f(I_D)$
 $V_{DD} = 1200 \text{ V}, R_{Gon} = 1.8 \text{ }\Omega, R_{Gon,o} = 0.51 \text{ }\Omega, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GS} = -3/18 \text{ V}$



5 Characteristics diagrams

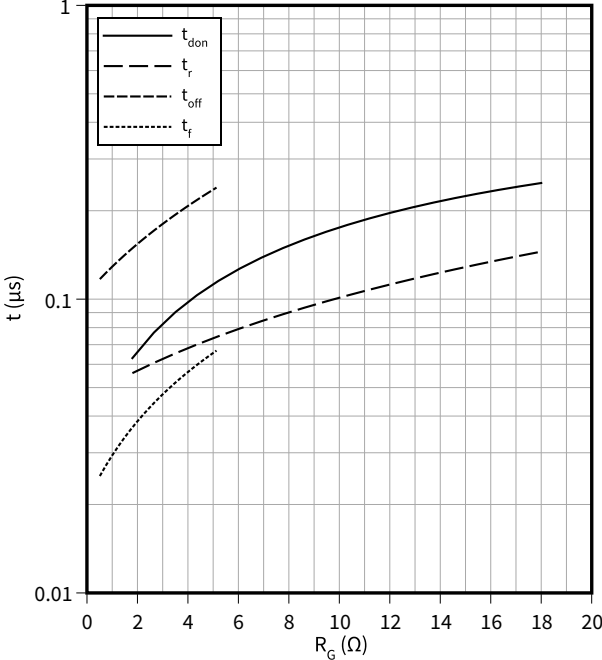
Switching times (typical), MOSFET, T1 / T2

$t = f(I_D)$
 $R_{Goff} = 0.51 \Omega$, $V_{DD} = 1200 \text{ V}$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



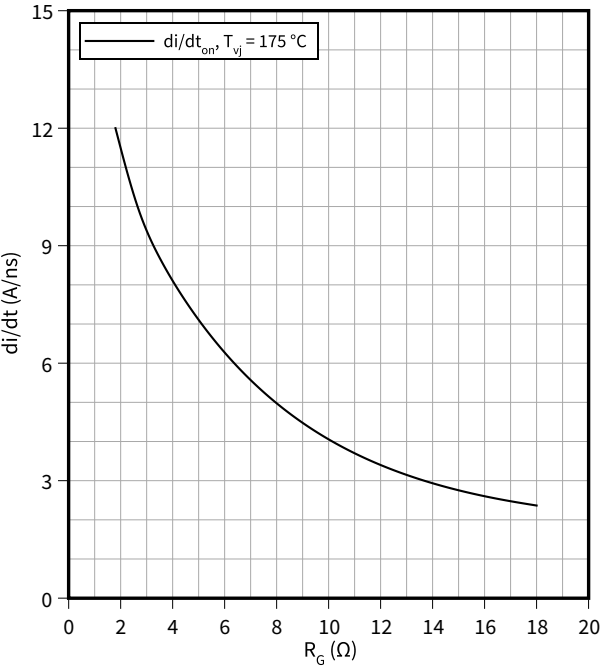
Switching times (typical), MOSFET, T1 / T2

$t = f(R_G)$
 $V_{DD} = 1200 \text{ V}$, $t_{dead} = 1000 \text{ ns}$, $I_D = 160 \text{ A}$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



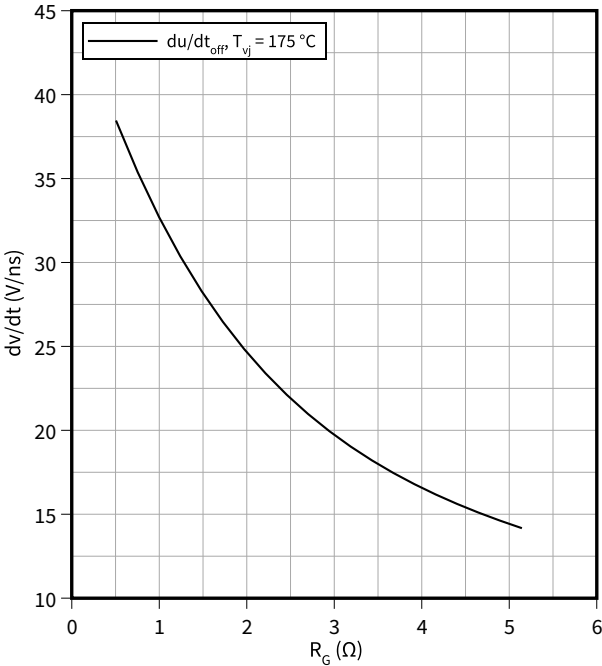
Current slope (typical), MOSFET, T1 / T2

$di/dt = f(R_G)$
 $V_{DD} = 1200 \text{ V}$, $I_D = 160 \text{ A}$, $V_{GS} = -3/18 \text{ V}$



Voltage slope (typical), MOSFET, T1 / T2

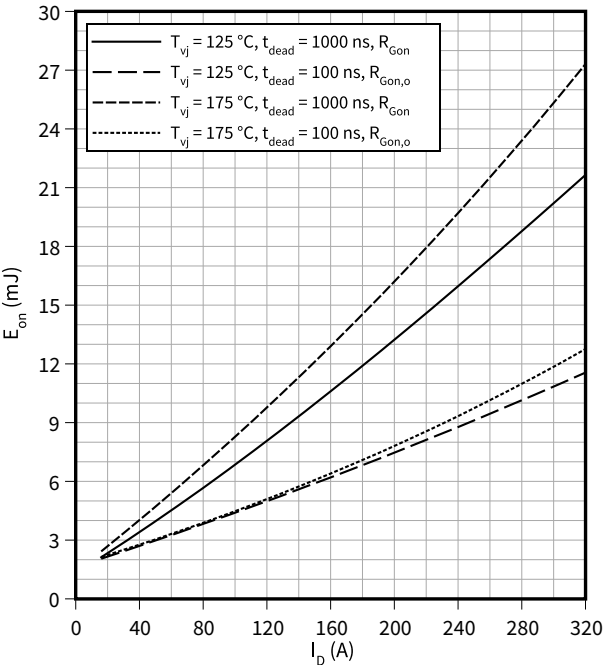
$dv/dt = f(R_G)$
 $V_{DD} = 1200 \text{ V}$, $I_D = 160 \text{ A}$, $V_{GS} = -3/18 \text{ V}$



5 Characteristics diagrams

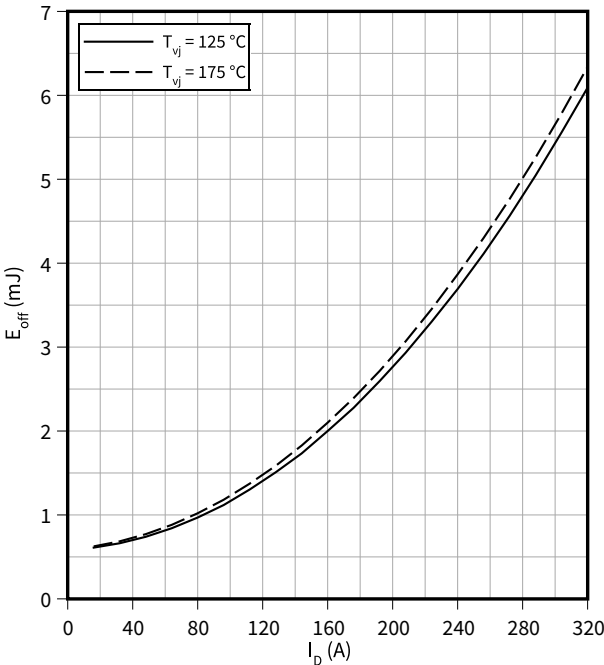
Switching losses (typical), MOSFET, T1 / T2

$E_{on} = f(I_D)$
 $V_{DD} = 1200\text{ V}$, $R_{Gon} = 1.8\ \Omega$, $R_{Gon,o} = 0.51\ \Omega$, $V_{GS} = -3/18\text{ V}$



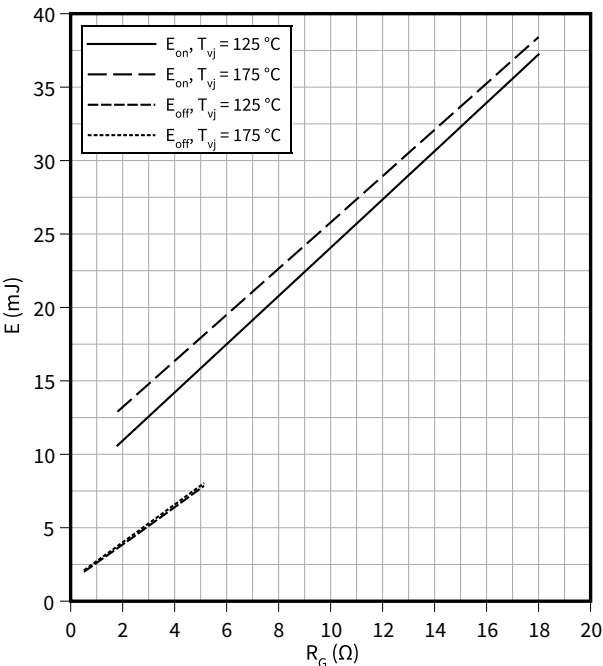
Switching losses (typical), MOSFET, T1 / T2

$E_{off} = f(I_D)$
 $R_{Goff} = 0.51\ \Omega$, $V_{DD} = 1200\text{ V}$, $V_{GS} = -3/18\text{ V}$



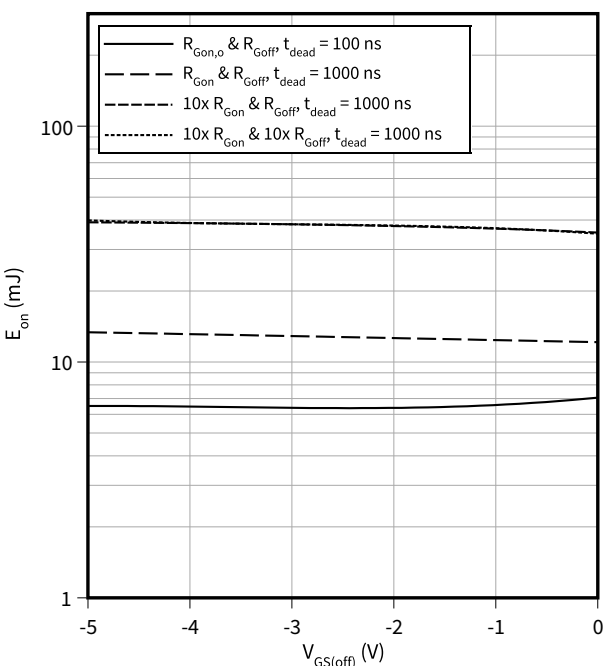
Switching losses (typical), MOSFET, T1 / T2

$E = f(R_G)$
 $V_{DD} = 1200\text{ V}$, $t_{dead} = 1000\text{ ns}$, $I_D = 160\text{ A}$, $V_{GS} = -3/18\text{ V}$



Switching losses (typical), MOSFET, T1 / T2

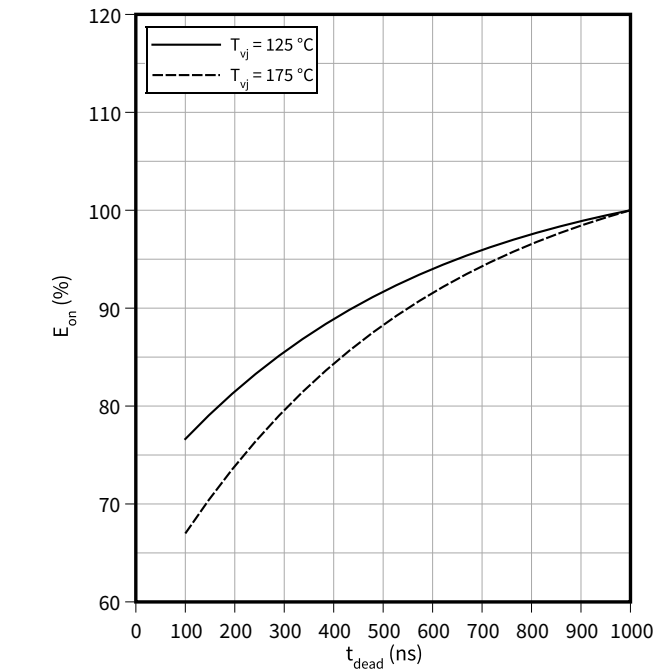
$E_{on} = f(V_{GS(off)})$
 $R_{Goff} = 0.51\ \Omega$, $V_{DD} = 1200\text{ V}$, $R_{Gon} = 1.8\ \Omega$, $V_{GS(on)} = 18\text{ V}$, $I_D = 160\text{ A}$, $R_{Gon,o} = 0.51\ \Omega$, $T_{vj} = 175\text{ °C}$



5 Characteristics diagrams

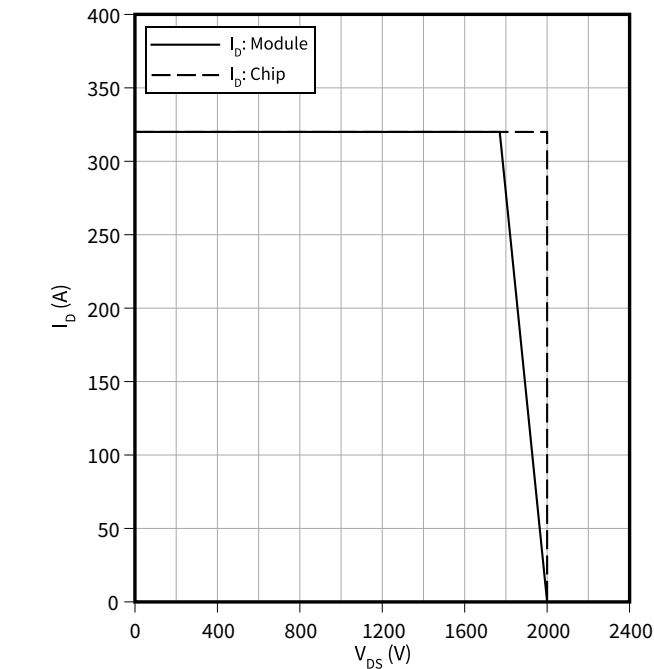
Switching losses (typical), MOSFET, T1 / T2

$E_{on} = f(t_{dead})$
 $R_{Gon} = 1.8 \Omega$, $I_D = 160 \text{ A}$, $V_{DD} = 1200 \text{ V}$, $V_{GS} = -3/18 \text{ V}$



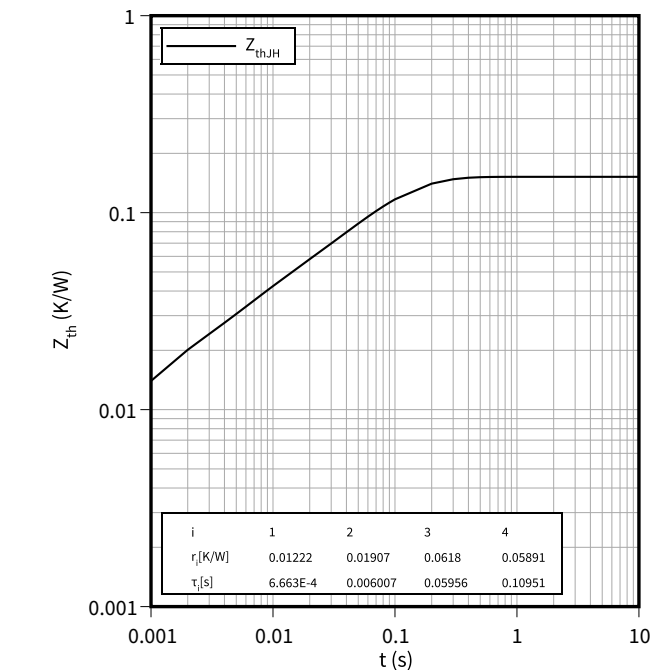
Reverse bias safe operating area (RBSOA), MOSFET, T1 / T2

$I_D = f(V_{DS})$
 $R_{Goff} = 0.51 \Omega$, $T_{vj} = 175 \text{ °C}$, $V_{GS} = -3/18 \text{ V}$



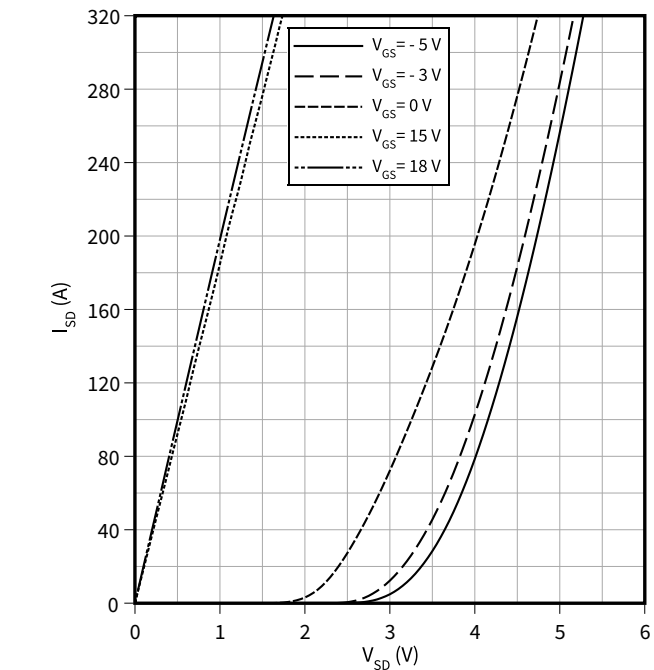
Transient thermal impedance, MOSFET, T1 / T2

$Z_{th} = f(t)$



Forward characteristic body diode (typical), MOSFET, T1 / T2

$I_{SD} = f(V_{SD})$
 $T_{vj} = 25 \text{ °C}$

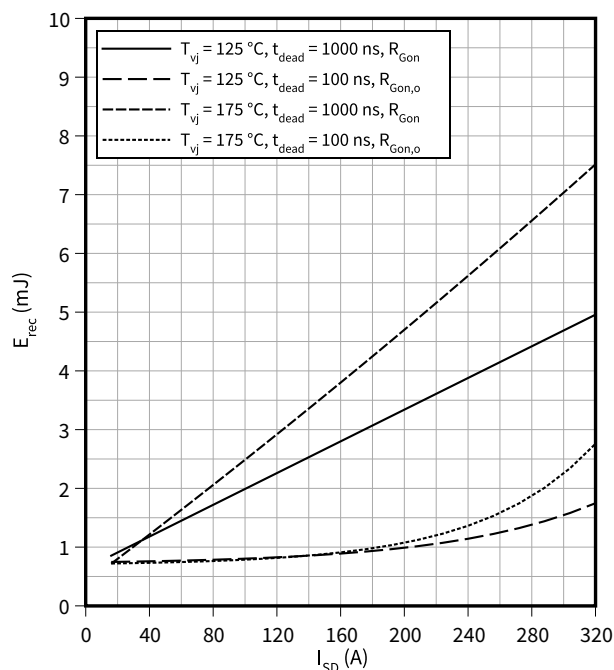


5 Characteristics diagrams

Switching losses body diode (typical), MOSFET, T1 / T2

$$E_{\text{rec}} = f(I_{\text{SD}})$$

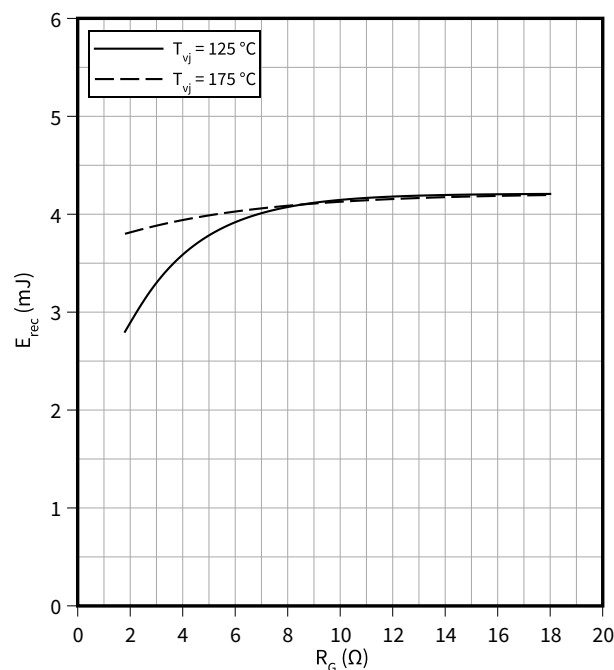
$R_{\text{Gon}} = 1.8 \Omega$, $R_{\text{Gon},o} = 0.51 \Omega$, $V_{\text{DD}} = 1200 \text{ V}$



Switching losses body diode (typical), MOSFET, T1 / T2

$$E_{\text{rec}} = f(R_{\text{G}})$$

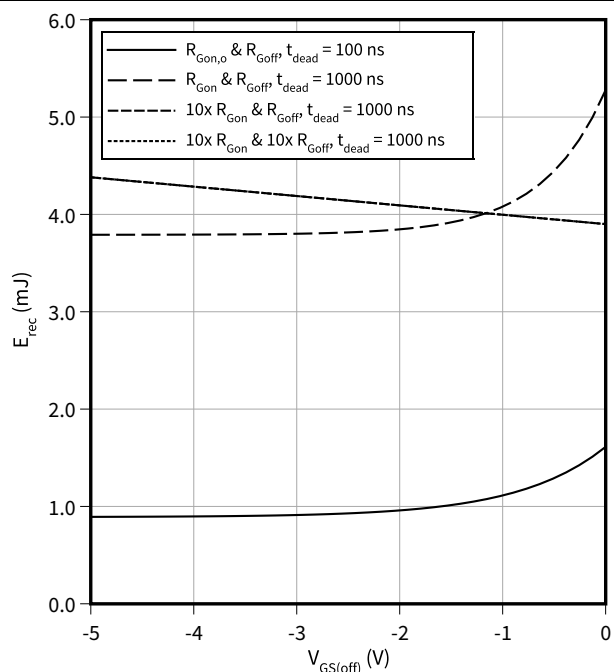
$t_{\text{dead}} = 1000 \text{ ns}$, $I_{\text{SD}} = 160 \text{ A}$, $V_{\text{DD}} = 1200 \text{ V}$



Switching losses body diode (typical), MOSFET, T1 / T2

$$E_{\text{rec}} = f(V_{\text{GS(off)}})$$

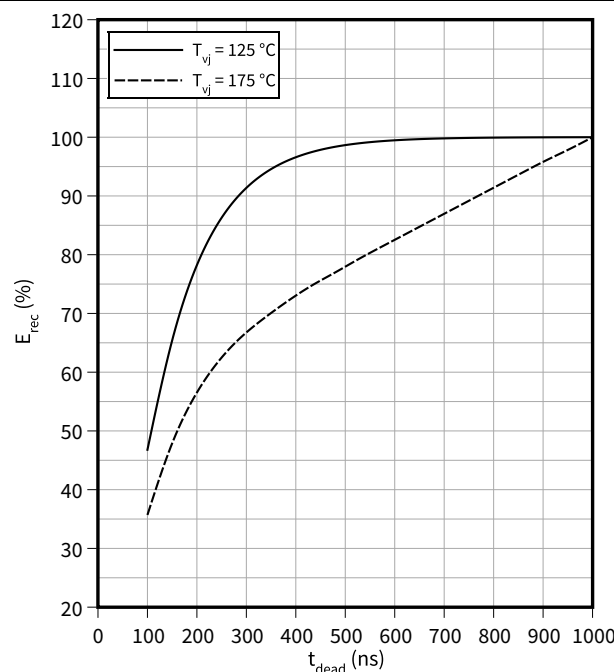
$R_{\text{Goff}} = 0.51 \Omega$, $R_{\text{Gon}} = 1.8 \Omega$, $V_{\text{GS(on)}} = 18 \text{ V}$, $I_{\text{SD}} = 160 \text{ A}$,
 $R_{\text{Gon},o} = 0.51 \Omega$, $V_{\text{DD}} = 1200 \text{ V}$, $T_{\text{vj}} = 175 \text{ °C}$



Switching losses body diode (typical), MOSFET, T1 / T2

$$E_{\text{rec}} = f(t_{\text{dead}})$$

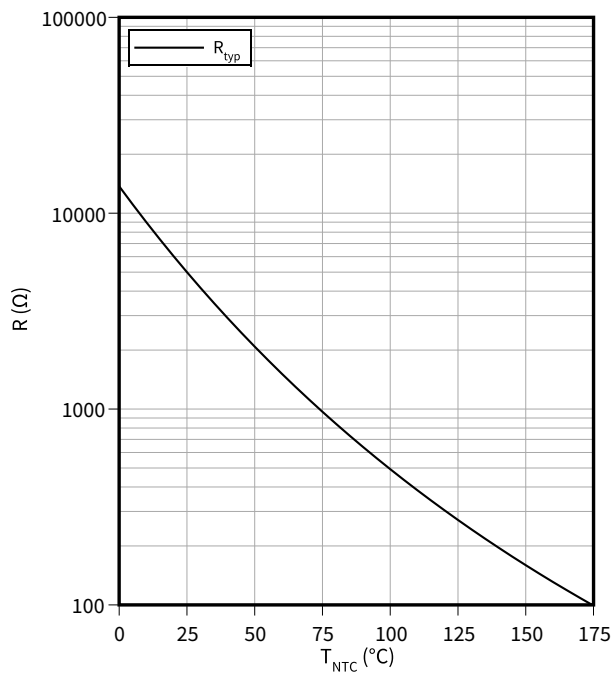
$R_{\text{Gon}} = 1.8 \Omega$, $I_{\text{D}} = 160 \text{ A}$, $V_{\text{DD}} = 1200 \text{ V}$, $V_{\text{GS}} = -3/18 \text{ V}$



5 Characteristics diagrams

Temperature characteristic (typical), NTC-Thermistor

$R = f(T_{NTC})$



6 **Circuit diagram**

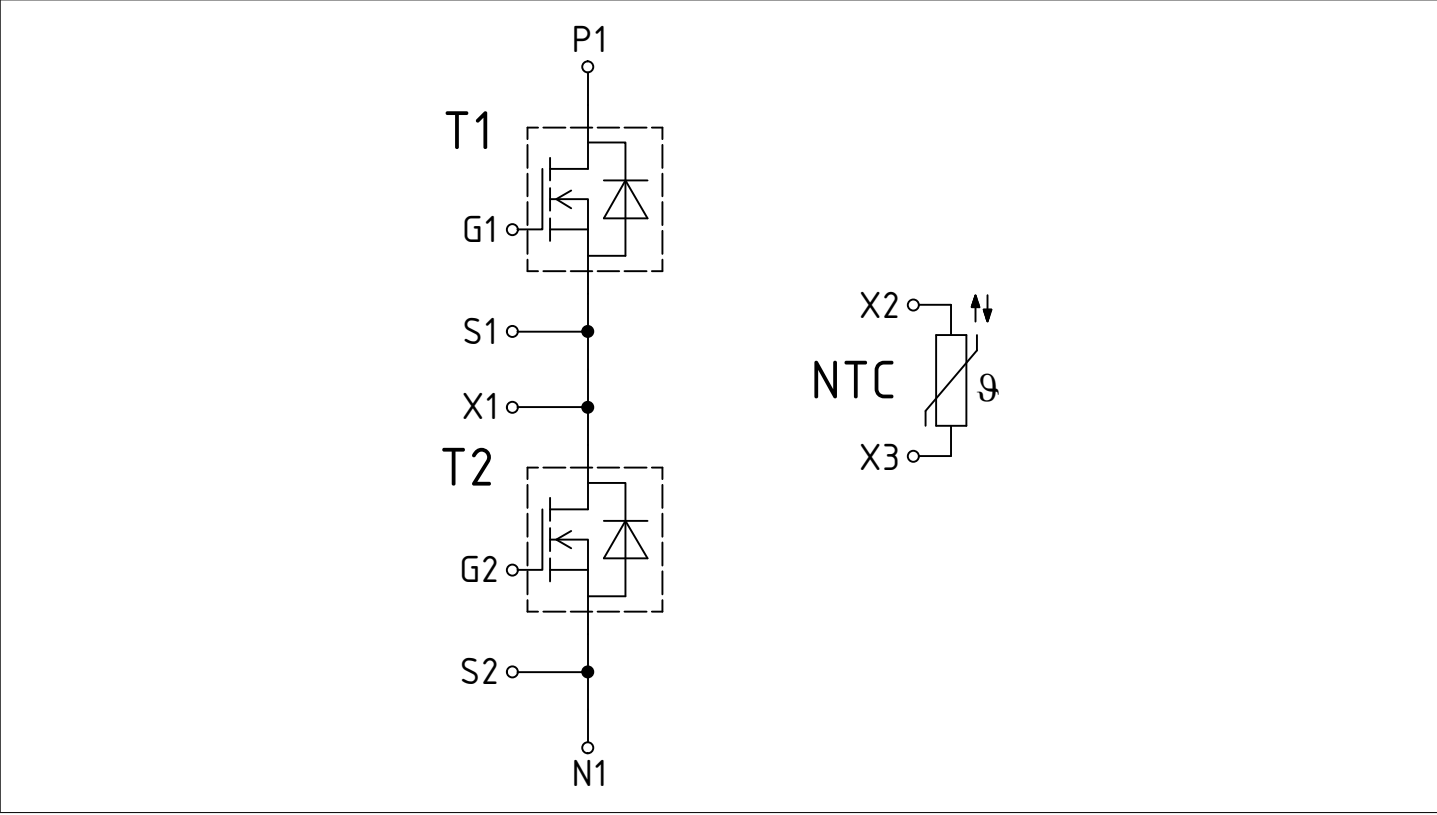


Figure 1

7 Package outlines

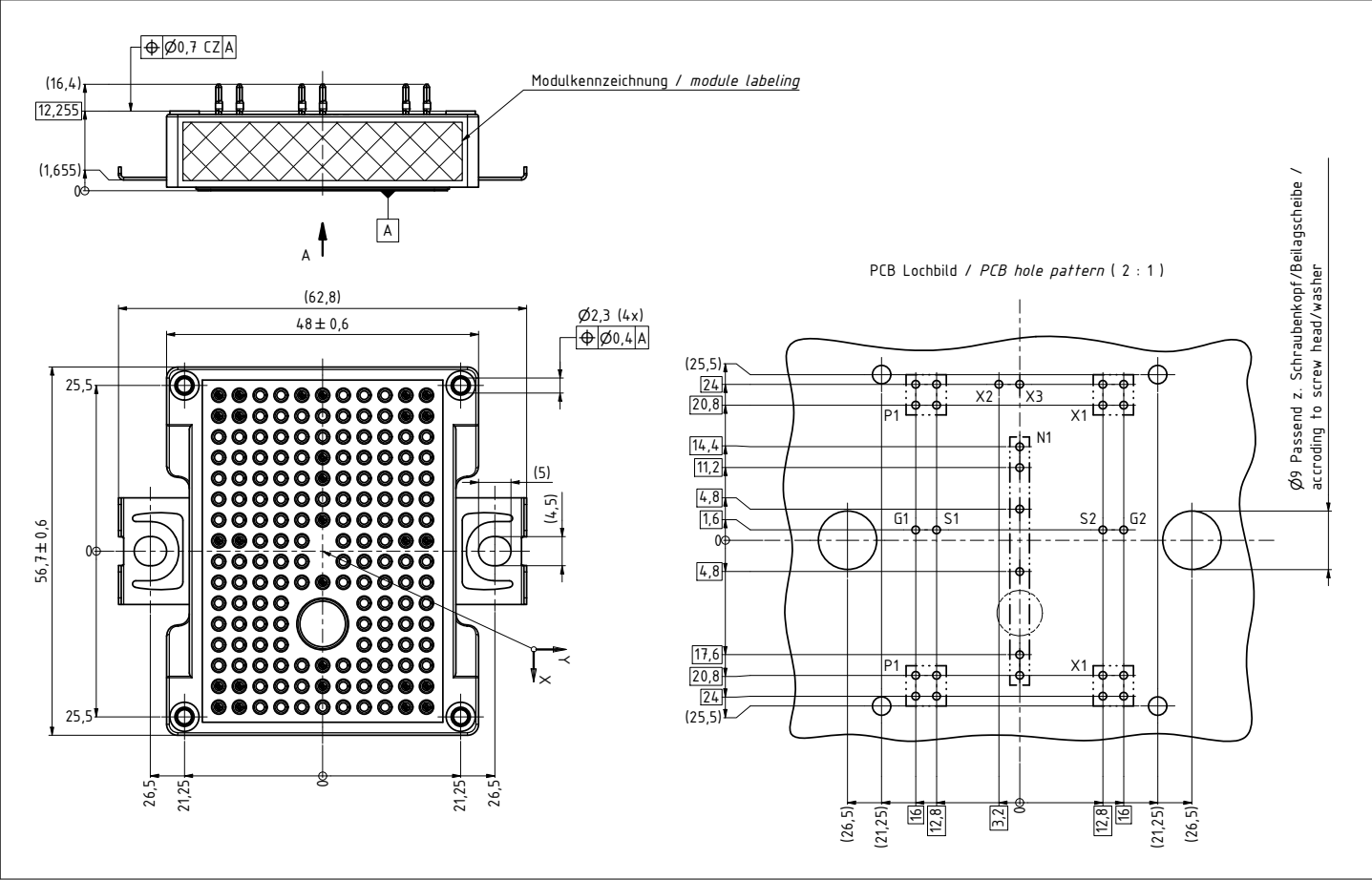


Figure 2

8 Module label code



Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	Content	Digit	Example
	Module serial number	1 – 5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 – 21	15
	Date code (production week)	22 – 23	30
Example	<div><div>7154914284655054991153071549142846550549911530</div></div>		

Figure 3



Revision history

Revision history

Document revision	Date of release	Description of changes
0.10	2024-03-18	Initial version
1.00	2024-08-23	Final datasheet
1.10	2024-10-17	Final datasheet

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